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IGBT

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Trench construction, and provides superior performance in demanding switching applications, offering both low on state voltage and minimal switching loss.

Features

- Optimized for Very Low V_{CEsat}
- Low Switching Loss Reduces System Power Dissipation
- 5 µs Short–Circuit Capability
- These are Pb–Free Devices

Typical Applications

• Power Factor Correction

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-emitter voltage	V _{CES}	600	V
Collector current @ Tc = 25°C @ Tc = 100°C	Ι _C	60 30	A
Pulsed collector current, T _{pulse} limited by T _{Jmax}	I _{CM}	120	A
Short–circuit withstand time V_{GE} = 15 V, V_{CE} = 300 V, $T_J \le +150^{\circ}C$	$V_{GE} = 15 \text{ V}, \text{ V}_{CE} = 300 \text{ V},$		μS
Gate-emitter voltage Transient Gate Emitter Voltage ($t_p = 5 \ \mu s, D < 0.010$)	V _{GE}	±20 ±30	V
Power Dissipation @ Tc = 25°C @ Tc = 100°C	P _D	167 67	W
Operating junction temperature range	TJ	-55 to +150	°C
Storage temperature range	T _{stg}	–55 to +150	°C
Lead temperature for soldering, 1/8" from case for 5 seconds	T _{SLD}	260	°C

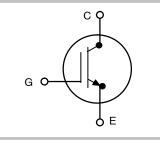
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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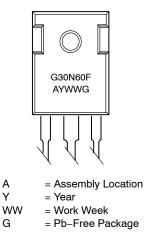
http://onsemi.com

30 A, 600 V V_{CEsat} = 1.5 V





MARKING DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping
NGTG30N60FWG	TO-247 (Pb-Free)	30 Units / Rail

THERMAL CHARACTERISTICS

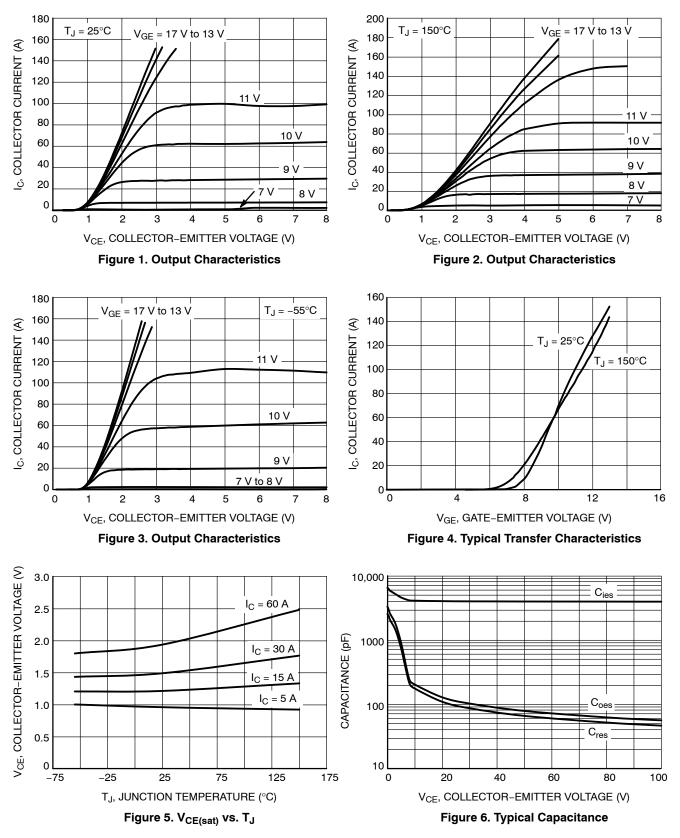
Rating	Symbol	Value	Unit
Thermal resistance junction-to-case, for IGBT	$R_{ ext{ heta}JC}$	0.75	°C/W
Thermal resistance junction-to-ambient	$R_{ hetaJA}$	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

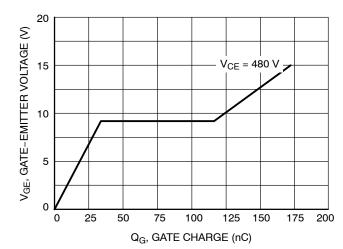
Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
STATIC CHARACTERISTIC						
Collector-emitter breakdown voltage, gate-emitter short-circuited	V_{GE} = 0 V, I _C = 500 µA	V _{(BR)CES}	600	-	-	V
Collector-emitter saturation voltage	V_{GE} = 15 V, I _C = 30 A V_{GE} = 15 V, I _C = 30 A, T _J = 150°C	V _{CEsat}	1.25 -	1.45 1.75	1.70 -	V
Gate-emitter threshold voltage	V_{GE} = V_{CE} , I_C = 200 μ A	V _{GE(th)}	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate- emitter short-circuited	$V_{GE} = 0 \text{ V}, V_{CE} = 600 \text{ V}$ $V_{GE} = 0 \text{ V}, V_{CE} = 600 \text{ V}, T_{J} = 150^{\circ}\text{C}$	I _{CES}	-	_ _	0.2 2	mA
Gate leakage current, collector-emitter short-circuited	V_{GE} = 20 V , V_{CE} = 0 V	I _{GES}	-	-	100	nA
DYNAMIC CHARACTERISTIC						
Input capacitance		C _{ies}	-	4100	-	pF
Output capacitance	V _{CE} = 20 V, V _{GE} = 0 V, f = 1 MHz	C _{oes}	-	115	-	
Reverse transfer capacitance		C _{res}	-	95	-	I
Gate charge total		Qg		170		nC
Gate to emitter charge	V _{CE} = 480 V, I _C = 30 A, V _{GE} = 15 V	Q _{ge}		34		
Gate to collector charge		Q _{gc}		83		
SWITCHING CHARACTERISTIC, INDUC		•				
Turn-on delay time		t _{d(on)}		81		ns
Rise time	1	tr		31		
Turn-off delay time	T _J = 25°C	t _{d(off)}		190		
Fall time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 30 \text{ A}$ B ₋ - 10 Q	t _f		110		
Turn-on switching loss	R _g = 10 Ω V _{GE} = 0 V/ 15 V*	E _{on}		0.65		mJ
Turn-off switching loss	1	E _{off}		0.65		
Total switching loss	1	E _{ts}		1.30		
Turn-on delay time		t _{d(on)}		80		ns
Rise time	1	t _r		32		
Turn-off delay time	− T _J = 150°C	t _{d(off)}		200		
Fall time	$V_{CC} = 400 \text{ V}, I_{C} = 30 \text{ A}$	t _f		230		
Turn-on switching loss	$R_g = 10 \Omega$ $V_{GE} = 0 V/15 V*$	E _{on}		0.80		mJ
Turn-off switching loss	1	E _{off}		1.1		
Total switching loss	1	E _{ts}		1.90		

*Includes diode reverse recovery loss using NGTB30N60FWG.





TYPICAL CHARACTERISTICS



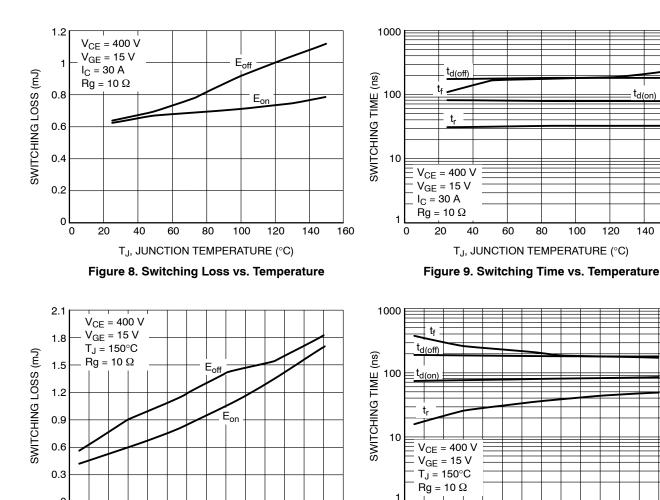


t_{d(on)}

140 160

I_C, COLLECTOR CURRENT (A)

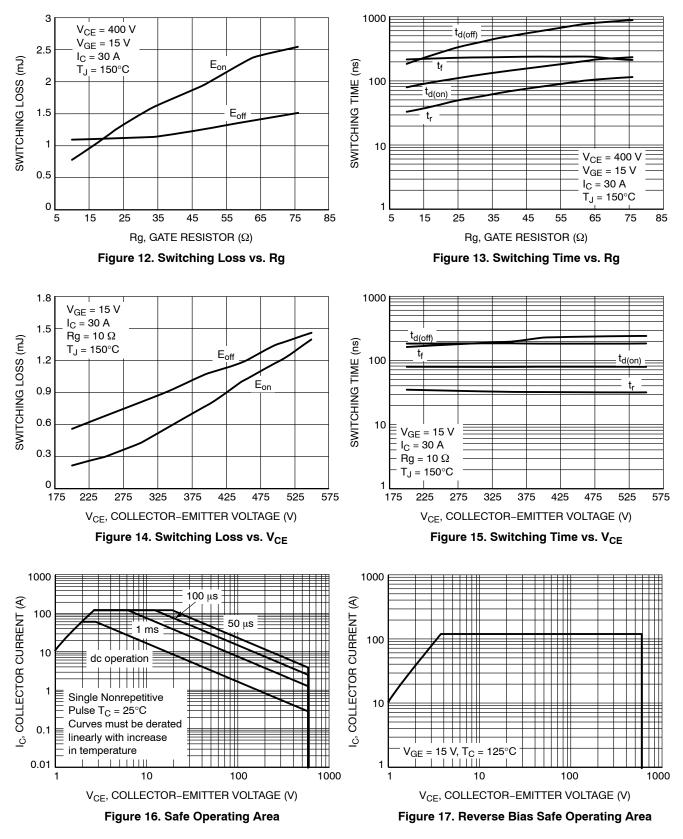
Figure 11. Switching Time vs. I_C



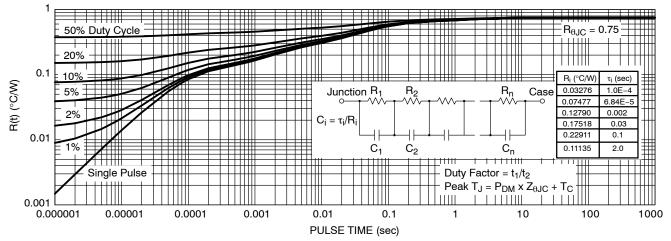
IC, COLLECTOR CURRENT (A)

Figure 10. Switching Loss vs. I_C

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS





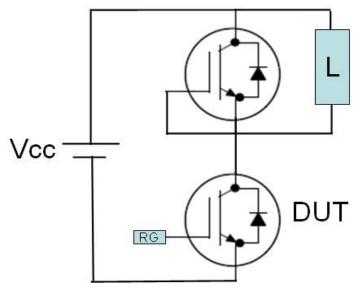
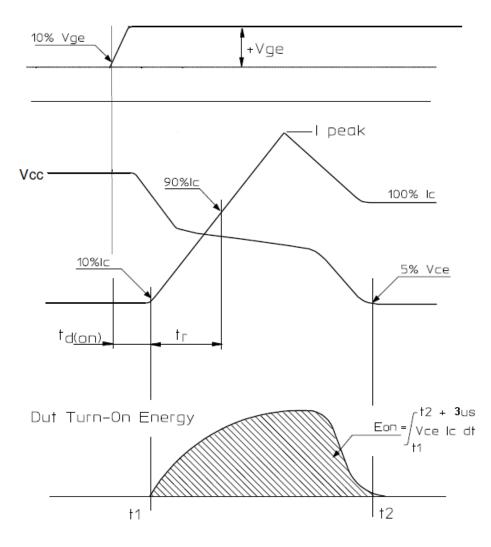
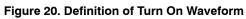


Figure 19. Test Circuit for Switching Characteristics





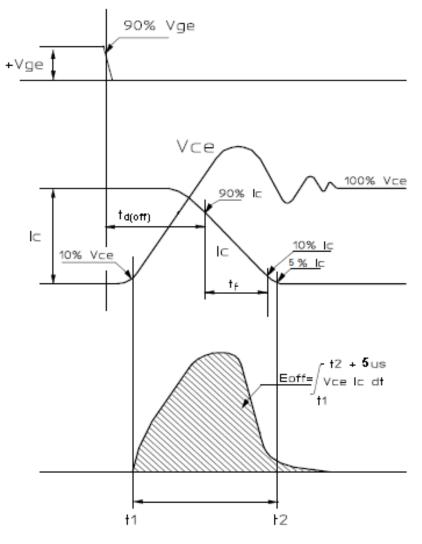
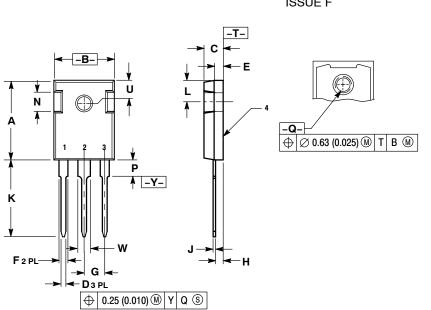


Figure 21. Definition of Turn Off Waveform

PACKAGE DIMENSIONS



TO-247 CASE 340L-02 ISSUE F

OTES: 1. DIMENSIONING AND TOLERANCING PER AI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER.							
		MILLIN	MILLIMETERS INCHES				
D	DIM	MIN	MAX	MIN	MAX		
	Α	20.32	21.08	0.800	8.30		
	В	15.75	16.26	0.620	0.640		
	С	4.70	5.30	0.185	0.209		
	D	1.00	1.40	0.040	0.055		
	E	1.90	2.60	0.075	0.102		
	F	1.65	2.13	0.065	0.084		
	G	5.45 BSC 0.215 BSC			BSC		
	H	1.50	2.49	0.059	0.098		
	J	0.40	0.80	0.016	0.031		
	Κ	19.81	20.83	0.780	0.820		
	L	5.40	6.20	0.212	0.244		
	Ν	4.32	5.49	0.170	0.216		
	Ρ		4.50		0.177		
	Q	3.55	3.65	0.140	0.144		
	U	6.15	BSC	0.242	BSC		
1	W	2.87	3.12	0.113	0.123		

STYLE 4:

PIN 1. GATE 2. COLLECTOR 3. EMITTER

4. COLLECTOR

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